

| ID | R _{Ds} (ON)(Typ) | VDSS | |
|----|---------------------------|------|--|
| 8A | 1.35Ω | 800V | |

Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability

Ordering Information

| Part Number | Package | Marking | Packing | Qty. |
|-------------|---------|---------|---------|--------|
| RS8N80F | T0-220F | RS8N80F | Tube | 50 PCS |

Absolute Maximun Ratings Tc= 25°C unless otherwise specified

| Symbol | Parameter | RS8N80F | Units |
|----------------|---|------------|-------|
| VDSS | Drain-to-Source Voltage | 800 | V |
| ID | Continuous Drain Current TC=25 $^{\circ}$ C | 8 | ۸ |
| IDM | Pulsed Drain Current (Note*1) | 32 | A |
| PD | Power Dissipation | 43.8 | W |
| VGS | Gate- to- Source Voltage | ±30 | V |
| EAS | Single Pulse Avalanche Engergy L = 10mH, VDD = 50V, RG = 25 Ω | 245 | mJ |
| | Maximum Temperature for Soldering | | |
| TL TPKG | Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds | 300 260 | °C |
| TJ and TSTG | Operating Junction and Storage Temperature Range | -55 to 150 | |

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the" Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

| Symbol | Parameter | RS8N80F | Units | Test Conditions |
|--------|-------------------------|---------|-------|---|
| RØJC | Junction-to-Case | 2.85 | °C/W | Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^\circ\!\mathrm{C}$ |
| RθJA | Junction-to- Ambient | 62.5 | | 1 cubic foot chamber,free air. |

OFF Characteristics TJ= 25° C unless otherwise specified

| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|--------|--|------|------|------|-------|----------------------|
| BVDSS | Drain- to- source Breakdown Voltage | 800 | | | V | VGS=0V,ID=250μ Α |
| IDSS | Drain- to- Source Leakage Current | | | 1 | μA | VDS=800V,VGS= 0V |
| | Gate- to- Source Forward Leakage | | | 100 | nA | VGS=30V ,VDS=0 V |
| IGSS | Gate- to- Source Reverse Leakage | | | -100 | | VGS=-30V ,VDS= 0V |

ON Characteristics TJ=25°C unless otherwise specified

| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|-------------|--|------|------|------|-------|----------------------|
| RDS(on) | Static Drain- to- Source On- Resistance(Note*2) | | 1.35 | 1.6 | Ω | VGS=10V,ID=4A |
| VGS(TH) | Gate Threshold Voltage | 3 | | 4 | V | VGS=VDS,ID=25 0μA |

Resistive Switching Characteristics Essentially independent of operating temperature

| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|---------|----------------------|------|------|------|-------|-----------------------------|
| td(ON) | Turn- on Delay Time | | 43 | | | |
| trise | Rise Time | | 28 | | nS | VDS=400V ID=8A RG=25Ω |
| td(OFF) | Turn- OFF Delay Time | | 244 | | | |
| tfall | Fall Time | | 54 | | | |



| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|--------|---------------------------------|------|------|------|-------|-------------------------------|
| Ciss | Input Capacitance | | 1778 | | | VGS=0V VDS=25V f=1.0MHz |
| Coss | Output Capacitance | | 128 | | pF | |
| Crss | Reverse Transfer Capacitance | | 27 | | | |
| Qg | Total Gate Charge | | 49 | | | VDS=640V |
| Qgs | Gate- to- Source Charge | | 6 | | nC | ID=8A VGS=10V |
| Qgd | Gate-to-Drain(" Miller") Charge | | 26 | | | |

Dynamic Characteristics Essentially independent of operating temperature

Source- Drain Diode Characteristics

| Symbol | Parameter | Min. | Тур. | Max. | Units | Test Conditions |
|--------|---------------------------|------|------|------|-------|-------------------------|
| IS | Continuous Source Current | | | 8 | А | Integral pn- diode |
| ISM | Maximum Pulsed Current | | | 32 | Α | in MOSFET |
| VSD | Diode Forward Voltage | | | 1.4 | V | IS=4A,VGS=0V |
| trr | Reverse Recovery Time | | 295 | | nS | VGS=0V |
| Qrr | Reverse Recovery Charge | | 1.7 | | μC | IS=8A,di/dt=100A /µs |

Notes:

- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 1%



Typical Feature Curve

Figure 1. Output Characteristics (T_J = 25°C)

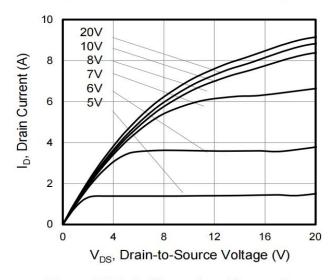
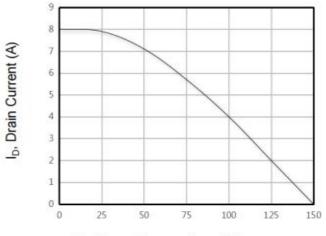
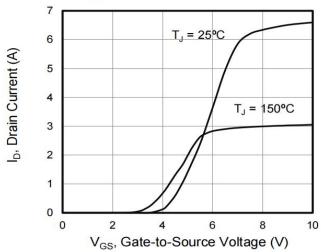


Figure 3. Drain Current vs. Temperature



T_J, Case Temperature (°C)

Figure 5. Transfer Characteristics



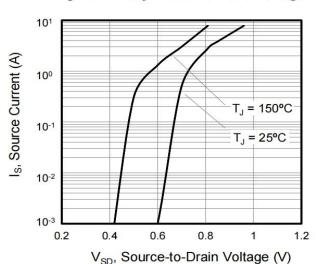


Figure 2. Body Diode Forward Voltage



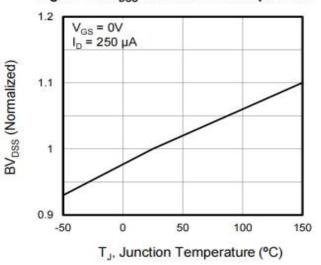
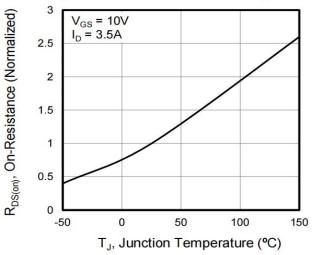


Figure 6. On-Resistance vs. Temperature





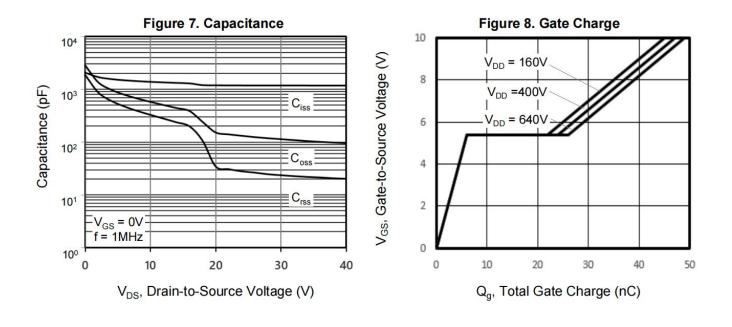
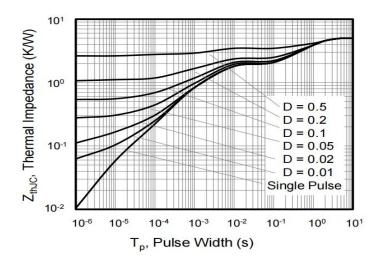


Figure 9. Transient Thermal Impedance





Test Circuits and Waveforms

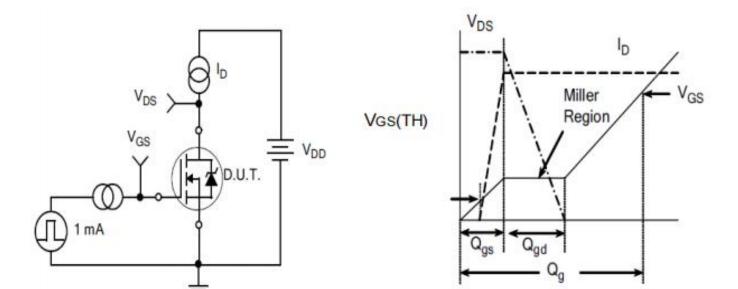
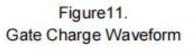


Figure10. Gate Charge Test Circuit



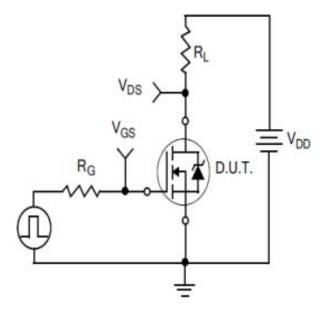


Figure12. Resistive Switching Test Circuit

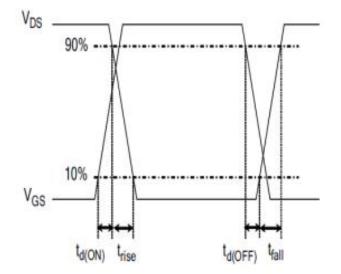
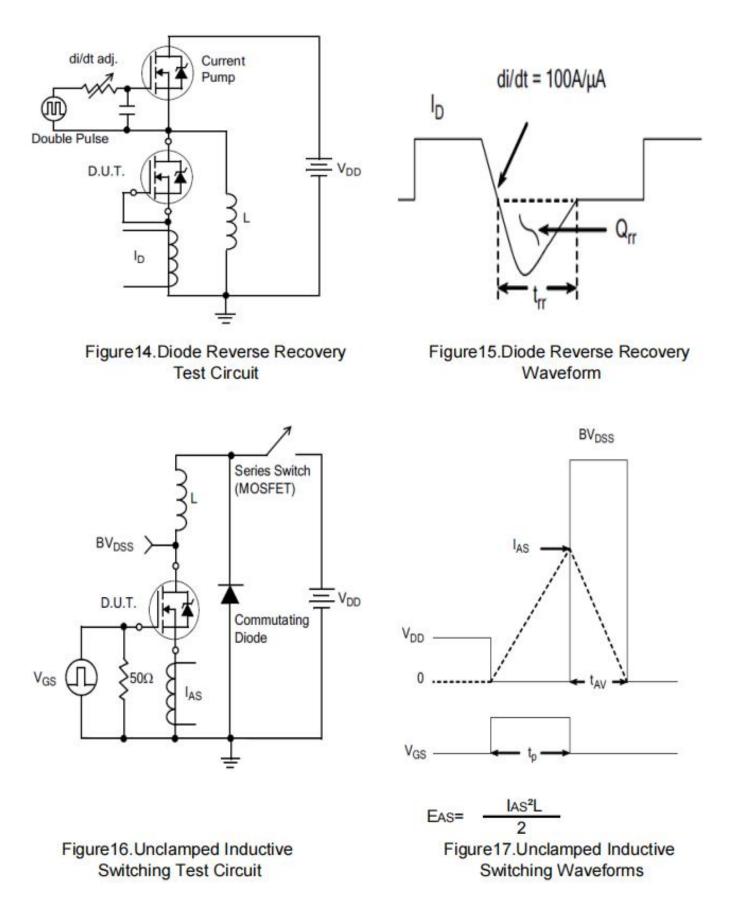


Figure13. Resistive Switching Waveforms

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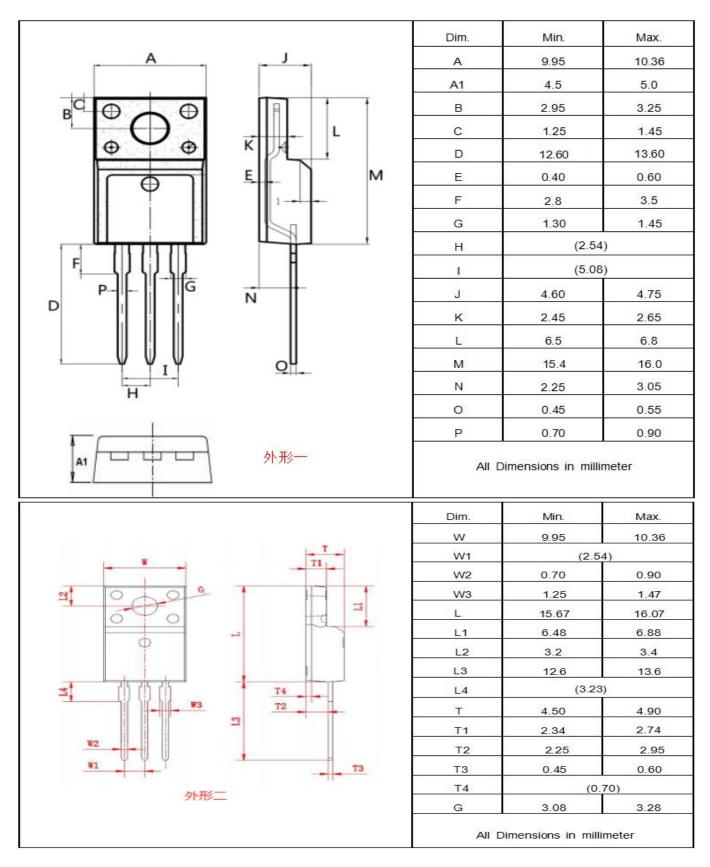


Test Circuits and Waveforms





Package outline drawing(TO-220F Unit: mm)





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